Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/690,694	TAKAMIZAWA ET AL.	
Examiner	Art Unit	
Madeleine AV Nguyen	2626	

SEARCHED				
Class	Subclass	Date	Examiner	
update		5/19/2005	AV	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East .	5/15-19/05	AV
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